



Temperature dependence of underdense nanostructure formation in tungsten under helium irradiation



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HIGHLIGHTS

- OKMC simulation of temperature window for fuzz formation.
- Stable He-V clusters prevent fuzz formation at low temperatures.
- Dissociation of He-V clusters prevent fuzz formation at high temperatures.
- Fuzz formation rate increases with increasing temperature.
- An incubation fluence observed in the simulations, similar to experimental observations.

ARTICLE INFO

Article history:

Received 8 December 2016

Received in revised form

11 April 2017

Accepted 17 April 2017

Available online 19 April 2017

Keywords:

Tungsten

Helium irradiation

Fuzz nanostructures

OKMC simulations

Temperature

ABSTRACT

Recently, tungsten has been found to form a highly underdense nanostructured morphology (“W fuzz”) when bombarded by an intense flux of He ions, but only in the temperature window 900–2000 K. Using object kinetic Monte Carlo simulations (pseudo-3D simulations) parameterized from first principles, we show that this temperature dependence can be understood based on He and point defect clustering, cluster growth, and detrapping reactions. At low temperatures (<900 K), fuzz does not grow because almost all He is trapped in very small He-vacancy clusters. At high temperatures (>2300 K), all He is detrapped from clusters, preventing the formation of the large clusters that lead to fuzz growth in the intermediate temperature range.

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1. Introduction

Tungsten is the prime plasma facing material (PFM) candidate for the divertor of future fusion devices due to its properties, such as low sputtering yield, low tritium retention, high melting point and high thermal conductivity [1–3]. Sections of the divertor closest to the strike point will reach high temperatures (≥ 1000 K) while exposed to large particle fluxes ($> 10^{23} \text{ m}^{-2} \text{ s}^{-1}$) of low-energy hydrogen and helium ions [4,5]. Experimental studies of W exposed

to these conditions report on the formation of voids and underdense W nanostructures (so called “fuzz”), shown in Fig. 1. Fuzz is formed not only due to (low energy) He irradiation of metals such as tungsten, molybdenum [6] or palladium [7], but also when exposed to mixed D₂-He plasmas [8]. Fuzz formation could be beneficial offering novel properties for these metals, e.g. as a means to make an underdense nanoporous surface layer with high chemical reactivity for catalytic activity. However, in the context of nuclear fusion, the formation of these nanostructures seems to over all be detrimental [9]. Several properties of W as PFM have been reported to worsen with the appearance of fuzz (voids and W nanostructures), such as decrease of the thermal conductivity and optical reflectivity of W [10–12] and surface effects under transient

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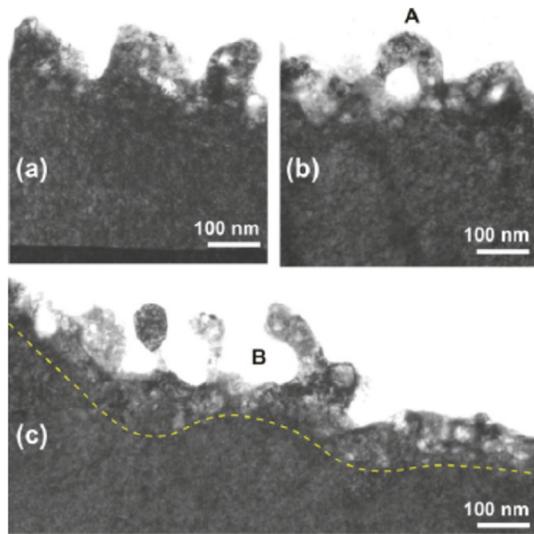


Fig. 1. Cross sectional TEM micrographs of the helium irradiated tungsten sample at different positions under a helium fluence $6 \times 10^{24} \text{ m}^{-2}$ [19]. Reprinted from Journal of Nuclear Materials, 418, S. Kajita, N. Yoshida, R. Yoshihara, N. Ohno, M-Yamagiwa, TEM observation of the growth process of helium nanobubbles on tungsten: Nanostructure formation mechanism, 152–158, Copyright (2011), with permission from Elsevier.

heat loads that might lead to an increase in the W release [13].

Experiments of He irradiation in linear divertor-plasma simulators [4] and with magnetron sputtering devices [14] provided similar results regarding fuzz formation. Baldwin et al. [4] studied the kinetics of fuzz growth, finding that it scales with the square root of time, $t^{1/2}$, at the studied temperatures: 1120 and 1320 K. At 1120 K the He energy threshold for nanostructure formation was determined to be around 35 eV [15] and the growth rate to increase with flux [8]. The role of defects in these processes has also been reported in Ref. [16]. A clear influence of temperature has been observed, revealing a limited temperature window for fuzz growth between, approximately, 900–2000 K [17–19]. Some theoretical studies have been carried out in order to explain the growth rate dependence with $t^{1/2}$. Modeling performed in Refs. [20,21] showed that the growth rate is driven by the balance of two processes: formation of He bubbles and their rupture at the surface. Along these lines, a four-step process has been proposed by Ito et al. [22,23] at 2000 K: (i) He ions penetrate the W surface; (ii) He diffusion and agglomeration even at interstitial sites occurs; (iii) He bubbles grow at both vacancy and the interstices and (iv) based on hybrid MD-MC simulations, they explained how He bubbles burst, forming fuzzy nanostructures. Further, the dynamics of small He clusters formed near the W surface has been extensively studied [24–29]. Nevertheless, no quantitative studies were found in the literature addressing why fuzz formation occurs only in this limited temperature window.

In the present study we report on an Object Kinetic Monte Carlo (OKMC) simulation of low energy He irradiation (60 eV) of W. Simulating a broad range of temperatures, from 700 to 2500 K, we have determined a fuzz growth temperature window, in agreement with published experiments [17–19]. In summary, at low temperatures (700 K), the great majority of He atoms are retained in monovacancies (He_nV_1 clusters), which remain stable. At intermediate temperatures (900–1900 K), He atoms are retained inside larger He_nV_m clusters, which grow to trigger the formation of fuzz-like structures. At high temperatures (2500 K), He atoms and vacancies are emitted from small He_nV_m clusters ($n < 40$, $m < 10$), preventing the formation of larger He_nV_m clusters and the growth of fuzz nanostructures.

2. Simulation methods

Our simulations have been performed using the open-source code MMonCa [30], parameterized with in house Density Functional Theory (DFT) calculations (see Table 3 of Ref. [31]), as well as values from literature [32,33], with the exception that pure He clusters (He_n) are assumed immobile and cannot emit He atoms. Although small clusters can migrate [34,35], the assumption is justified by cluster diffusion being slowed down with the cluster size and strongly suppressed by impurities and interstices [22,23,36]. In addition, trap mutation reactions [37,38] have been considered. These trap mutation reactions, enhanced near the irradiation surface [39–41], constitute an efficient way of He trapping ($\text{He}_n \rightarrow \text{He}_n\text{V} + \text{I}$). The maximum He/V ratio allowed in these simulations is 9, i.e., He_{9m}V_m clusters. This limit is based on theoretical calculations [42,43] as well as on experimental observations [44]. As DFT calculations are only possible for small clusters, we have approximated the DFT values to a power law for large He_nV_m clusters [31]:

$$E_b(\text{He} \rightarrow \text{He}_{n-1}\text{V}_m) = 4.43 \cdot \left(\frac{n}{m}\right)^{-0.28}, \quad (1)$$

where E_b is the binding energy and n and m , the number of He atoms and vacancies in the cluster, respectively. A maximum value for the binding energy of a He atom to a He_nV_m cluster was set to ~ 6 eV [45].

Thin W boxes of $40 (X) \times 4 (Y) \times 20 (Z, \text{height}) \text{ nm}^3$ were used to carry out pseudo-3D simulations. The width of the simulation box (X dimension) was taken as large as the expected size of the tendrils that will be formed (30 ± 10 nm, as reported experimentally in Ref. [46]). The depth of the box (20 nm) allows simulating the migration of He ions (for an implantation depth of ~ 1.3 nm as calculated by SRIM, see below). Full 3D boxes were very computationally demanding, turning out impractical. Periodic boundary conditions (PBCs) were used only in the two largest lateral surfaces (normal to Y direction). Free surfaces were considered in the two smaller surfaces (normal to X direction), in order to let the material expand along X and Z directions and thus, reproduce the evolution of the surface roughness (Fig. 2). The top surface (normal to the Z -axis) was considered as a desorption surface, whereas atoms reaching the bottom surface were considered to move further deep into the bulk and thus ignored. Each simulation box was composed of small cells ($0.5 \times 0.5 \times 0.5 \text{ nm}^3$), named *mesh elements*. The *mesh elements* out of the W box were considered as vacuum. If the volume of the He atoms retained in a given cluster (assuming 0.0033 nm^3 per single He) was equal or larger than the volume of a *mesh element* (0.125 nm^3), then the closest vacuum *mesh element* above the surface was changed to a W *mesh element*, thus simulating the surface growth. When the distance of a cluster to the desorption surface was lower than 0.2 nm, the whole cluster was considered to burst. Helium atoms were discarded from the simulation and a number of W fuzz *mesh elements* equal to the volume of released He atoms was changed to vacuum, thus simulating the bubble burst. This approach to fuzz growth is similar to that observed in MD simulations presented in Ref. [21] and based in previous MD results [47]. However, with the current methodology, fuzz grows not only normal to the surface (Z) but also along the X direction, not included in the former study. The implantation depth of He ions was calculated with the SRIM code [48], by irradiating W with He ions at 60 eV. Helium ions were implanted following a Gaussian distribution in depth taking into account the surface height where and when implanted (see Fig. 3).

The flux was $5 \times 10^{22} \text{ m}^{-2} \text{ s}^{-1}$, taking into account the reflection yield provided by SRIM. When a He ion is reflected, it was not

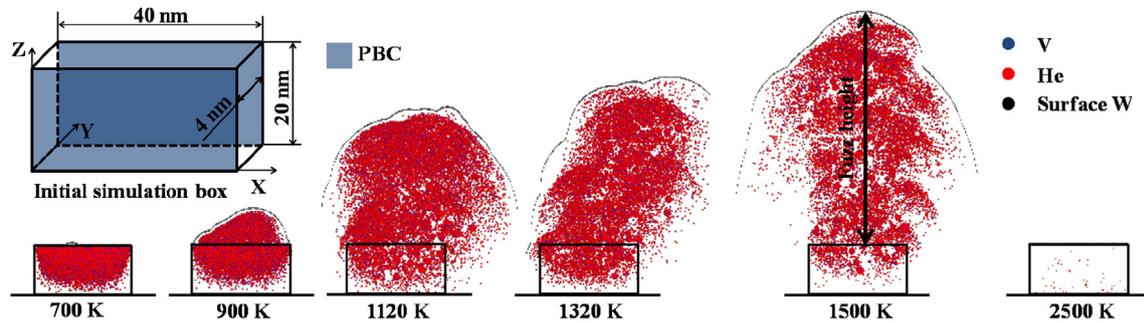


Fig. 2. Dimensions of the simulation boxes and schematic representation of W surface growth (fuzz growth) at different temperatures after 3 s of He (60 eV) irradiation.

implanted in the simulation box but time was allowed to evolve. Fuzz was considered to be the W region that grows above the initial surface layer (Fig. 2). Helium irradiation times of up to 3 s, at impacting energies of 60 eV, were simulated at eight different temperatures: low temperature (700 K), intermediate temperatures (900, 1120, 1320, 1500, 1700, 1900, 2100 and 2300 K) and high temperature (2500 K). In the case of 1700 K only results up to 1.25 s were obtained. The high temperature cases (1900, 2100 and 2300 K) were only simulated up to 0.25 s. At these temperatures, the high number of thermally activated reactions leads to very high computational times. Nevertheless, the temperatures reported in this study constitute a representative set to study the temperature influence on fuzz formation.

3. Results and discussion

The modelled W fuzz growth after 3 s of He irradiation is shown in Fig. 2. At low temperature (700 K), the whole simulation box (20 nm deep) becomes populated by He_nV_m clusters. However, these clusters are too small to cause any significant surface-, and hence, fuzz-growth. At intermediate temperatures, fuzz growth due to the accumulation of He atoms in larger He_nV_m clusters is observed: at 900 K, fuzz slightly grows, only normal to the surface. Between 1120 and 1500 K, there is a significant surface growth in both directions, normal to the surface (Z) and along the X axis. The higher the temperature, the more pronounced the fuzz growth. This trend is also observed at 1700 and 1900 K (see Fig. 4). At 2100 K

starts a change in the regime of fuzz growth and He retention (see below) that ends at high temperature (2500 K). Finally, at 2500 K, neither fuzz growth nor He retention takes place. These results are in very good agreement with the experimentally reported temperature window for fuzz growth (900–2000 K) [17–19]. It is noteworthy that our modeling uses a general parameterization for He irradiation in W, which was previously employed to reproduce very different irradiation conditions [31,49,50]. Moreover, in our simulations the mean diameter of He_nV_m clusters at a fluence of $1.5 \times 10^{23} \text{ m}^{-2}$ is 0.36 and 0.44 nm at 700 and 900 K, respectively. These results are in very good agreement with experimental values of He nano-bubbles mean diameter of 0.36 nm (at $1.2 \times 10^{23} \text{ m}^{-2}$ and 623–673 K) and 0.62 nm (at 10^{23} m^{-2} and 1073 K), as reported in Refs. [51,52]. Nevertheless, the ellipsoidal shape reported in the experiments cannot be reproduced with our code, which considers the He_nV_m clusters as spheres.

The fuzz height for different temperatures as a function of time (i.e., fluence) is presented in Fig. 4. Over all, the growth rate increases with temperature. At low temperature (700 K), the absence of fuzz growth previously described is observed. At 900 K a slightly fuzz growth is seen, which is speed up between 1120 and 1500 K (up to 14.5, 56 and 94 nm, respectively, at the end of the 3 s simulation). Fuzz growth is much faster at 1700, 1900 and 2100 K, as observed even for short irradiation times. At 2300 K, the fuzz growth rate decreases (with respect to 1900 and 2100 K). It slows down as He emission from He_nV_m clusters increases due to the high temperature, making more difficult the growth of large He_nV_m clusters. This balance between He emission and cluster growth is discussed in detail later in this Section. At high temperature (2500 K), no fuzz growth occurs at all. The fuzz growth obtained from experimental data at 1120 and 1320 K (square root temporal dependence) [4] is also plotted. For short times scales, the temporal evolution obtained in our simulations does not follow the square root dependence, see Fig. 4(b). A recent report [9] indicates that fuzz growth following the square root dependence only starts after accumulating an incubation fluence. Although the experiments were carried out at different irradiation conditions (He ion energy, flux and temperature), the incubation fluence is qualitatively comparable to our simulation results (see animation in the Supplementary Material). It can also be observed that the higher the temperature, the lower the incubation fluence, being almost negligible from 1700 K. A full description of the temporal evolution is anyhow out of the scope of this study. Detailed experiments at low fluences for different temperatures and fluxes would allow for better understanding and prediction of the incubation fluence as a threshold for fuzz formation.

Supplementary video related to this article can be found at <http://dx.doi.org/10.1016/j.jnucmat.2017.04.021>.

It is noteworthy that He retention alone (shown as a function of time and fluence for the temperatures considered in this work in

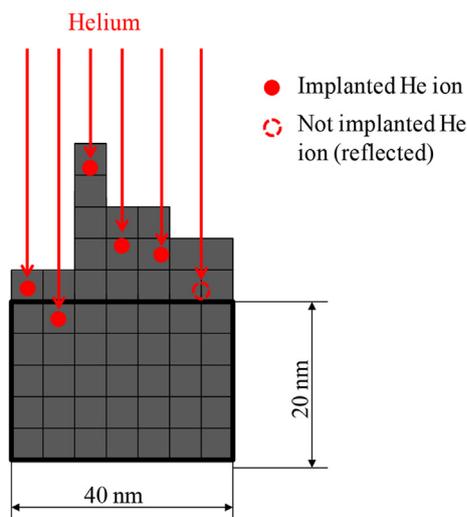


Fig. 3. MMonCa takes into account the height of the W surface and the reflection yield when implanting He ions at depths calculated by SRIM.

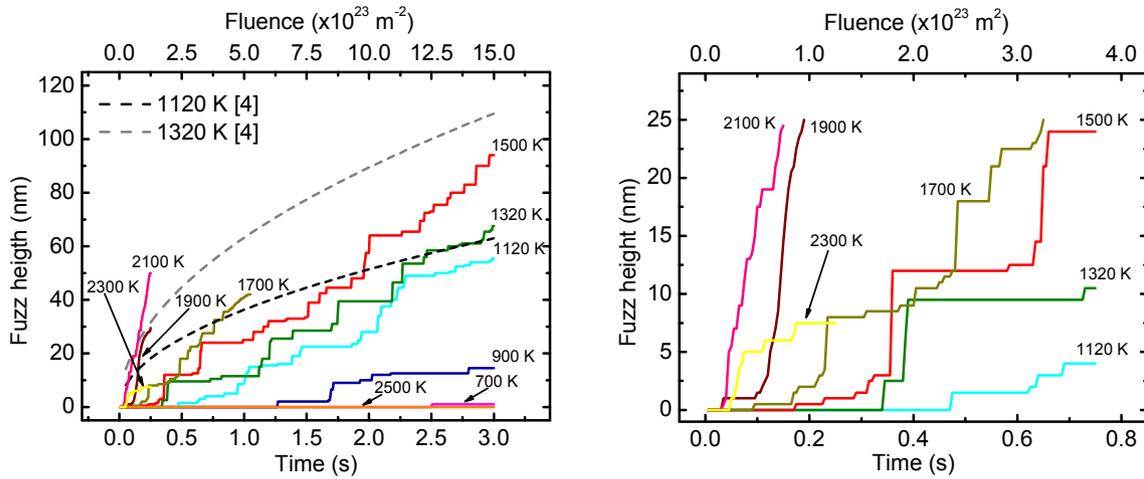


Fig. 4. (a) Fuzz height as a function of time (i.e. fluence) at the simulated temperatures. Fuzz height obtained from experimental data at both 1120 and 1320 K [4], are also plotted. (b) A zoom in into the fuzz height evolution in the first 0.8 s of irradiation.

Fig. 5) cannot explain fuzz growth. In fact, up to irradiation times of 2.5 s, the He retention fraction at 700 K (a temperature showing no fuzz growth) is higher than that at 900, 1120, 1320 and 1500 K (which show fuzz formation). Helium retention increases up to a temperature of 1900 K. At 2100 K and higher temperatures, the He retention decreases as the He emission from clusters starts to play a more important role. An analysis of the He population in different types of clusters evidences that at low temperatures, the incoming He ions are trapped at first in pure He_n clusters. Once they reach 9 atoms (He_9) at 700 K, they emit a self-interstitial atom (SIA) becoming stable He_9V_1 clusters (trap mutation). Indeed, 95.9% of He is retained in He_9V_1 clusters (see Fig. 6), indicating almost no coalescence of clusters. The absence of large He_nV_m clusters suppresses fuzz formation.

At 900 K, a similar process is observed regarding trap mutation: only He_9 clusters are able to emit a SIA to become He_9V_1 . However, the crucial difference is that at this temperature, He atoms are emitted from He_nV_m clusters. On the one hand, this lowers He retention. On the other hand, some of the emitted He atoms are trapped in the vicinity of the emitting clusters, favoring coalescence of existing and new He_nV_m clusters, resulting in the formation of larger He_nV_m clusters that promote fuzz growth.

At higher temperatures (1120, 1320 and 1500 K), He retention

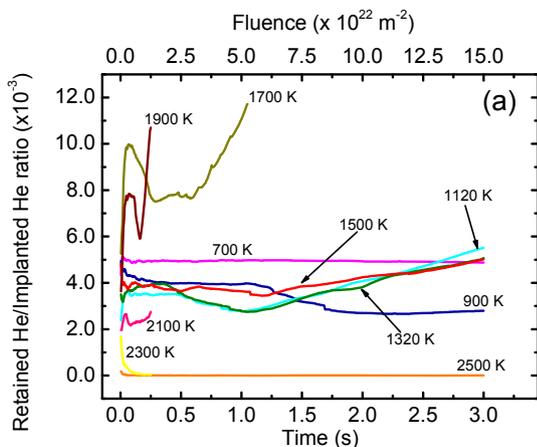


Fig. 5. Retained He fraction as a function of time (and fluence) for different temperatures.

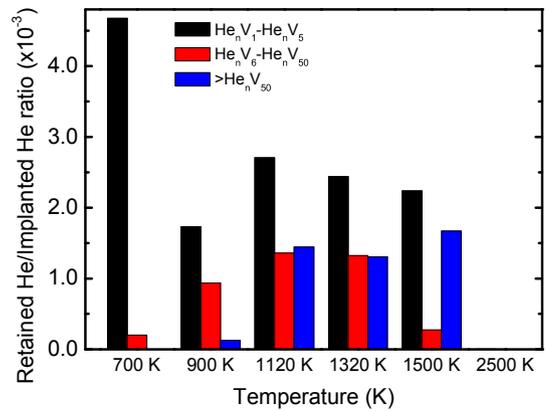


Fig. 6. He retention at 700, 900, 1120, 1320, 1500 and 2500 K sorted by cluster size after up to 3 s of He irradiation.

decreases up to irradiation times of 1 s. Beyond 1 s, the presence of the already formed He_nV_m clusters increases the emission of He atoms, and thus the coalescence between He_nV_m clusters. As a result, He retention increases in a similar way for the three temperatures, resulting in a higher retention than at 900 K. At these temperatures, fuzz growth occurs not only normal to the irradiation surface but also along the X direction, allowing more volume for He trapping and thus increasing the retained He fraction. Further, the number of He atoms needed to enable trap mutation decreases with increasing temperature. For instance, at 1500 K even He_4 clusters are able to emit a SIA to become a He_4V_1 , similar to results reported in Refs. [41,53]. This trend strongly promotes trap mutation and therefore, He trapping with increasing temperature. The emission of He atoms from He_nV_m clusters also increases with temperature, favoring cluster coalescence. The higher concentration of He atoms in large clusters at these temperatures (Fig. 6) leads to efficient fuzz growth. A different regime in He retention is observed at 1700 and 1900 K. Although only short simulations were carried out, the trend is clearly observed: a much higher He retention rate can be observed. The process described above also applies at these temperatures, but at a much more accelerated rate due to the higher temperatures. The processes governing the temperature dependence of fuzz growth are therefore, (i) trap mutation and (ii) He emission from He_nV_m clusters, with the subsequent coalescence and formation of larger He_nV_m clusters.

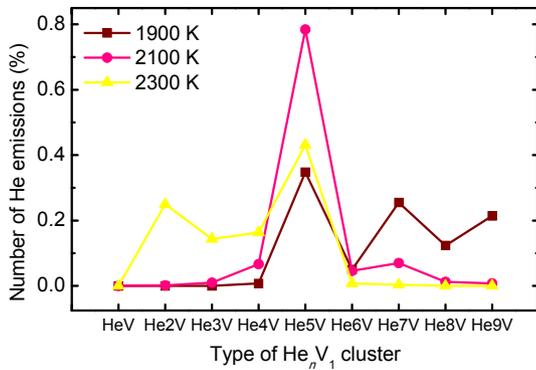


Fig. 7. Number of He emissions for different He_nV_1 clusters with respect with the total He emissions in He_nV_1 clusters.

At 2100 and 2300 K, large clusters are formed and thus fuzz still grows. However, the temperature is sufficiently high to dissociate the He_nV_m clusters by emitting He atoms. The reason behind such transition can be derived from Fig. 7. The maximum emission of He atoms at 1900, 2100 and 2300 K occurs when the vacancy contains 5 He atoms, as it has the lowest binding energy

Table 1

Binding energy of a He atoms to a vacancy (He_nV_1) as a function of the number of He atoms in the vacancy.

Cluster	Binding energy (eV)
HeV (He → V)	4.67
He ₂ V (He → HeV)	3.22
He ₃ V (He → He ₂ V)	3.17
He ₄ V (He → He ₃ V)	3.23
He ₅ V (He → He ₄ V)	2.23
He ₆ V (He → He ₅ V)	2.77
He ₇ V (He → He ₆ V)	2.35
He ₈ V (He → He ₇ V)	2.53
He ₉ V (He → He ₈ V)	2.13

(2.23 eV, see Table 1). At 1900 K, the equilibrium between formation and dissociation of He atoms in He_nV_m clusters takes place in vacancies with 7–9 He atoms (He_7V_1 to He_9V_1), which leads to the formation of large and stable clusters and thus, fuzz growth and He retention. At 2100 K starts the change in regime. The increase in temperature causes the equilibrium to appear at vacancies with 5 He atoms (He_5V_1), which leads to the formation of large but instable clusters: fuzz grows but the clusters are dissolved at a higher rate and He retention decreases. At 2300 K, the change in regime continues: the equilibrium appears at vacancies with 2–4 He atoms (He_2V_1 to He_4V_1) which have binding energies of the order of 3 eV (see Table 1). This leads to a lower number of large He_nV_m clusters, i.e., a lower fuzz growth rate and a lower He retention. Bursting of some of these scars but large He_nV_m clusters may be behind the formation of pitholes observed experimentally at high temperatures [17].

Finally, at a high temperature (2500 K) the transition to the new regime ends. He emission from the formed He_nV_m clusters dominates, suppressing further cluster formation or growth, and thus, fuzz formation. In fact, almost no He is retained at 2500 K (Fig. 6). In this case, the emitted He atoms cannot be trapped, but they migrate until they have reached the surface and desorb or migrate to the bulk.

In Fig. 8, the vacancy concentration profile in the fuzz region at 900, 1120, 1320 and 1500 K is shown. The profile peaks become less pronounced with increasing temperature. The highest vacancy concentration is reached at 900 K with $\sim 6.8 \text{ nm}^{-3}$, i.e., 10.8% of the W atoms are displaced from their lattice positions forming vacancies. The vacancy concentration reaches successive peaks, which tend to be lower with the increasing fuzz height and temperature. This result indicates that, as fuzz height increases, the incoming He ions interact mainly with the He_nV_m clusters closest to the surface. For a better comparison of vacancy concentration at different temperatures, we have also calculated the mean vacancy concentration in the fuzz region (inset of Fig. 8). As a result, we observe that the higher the temperature, the lower the mean vacancy concentration.

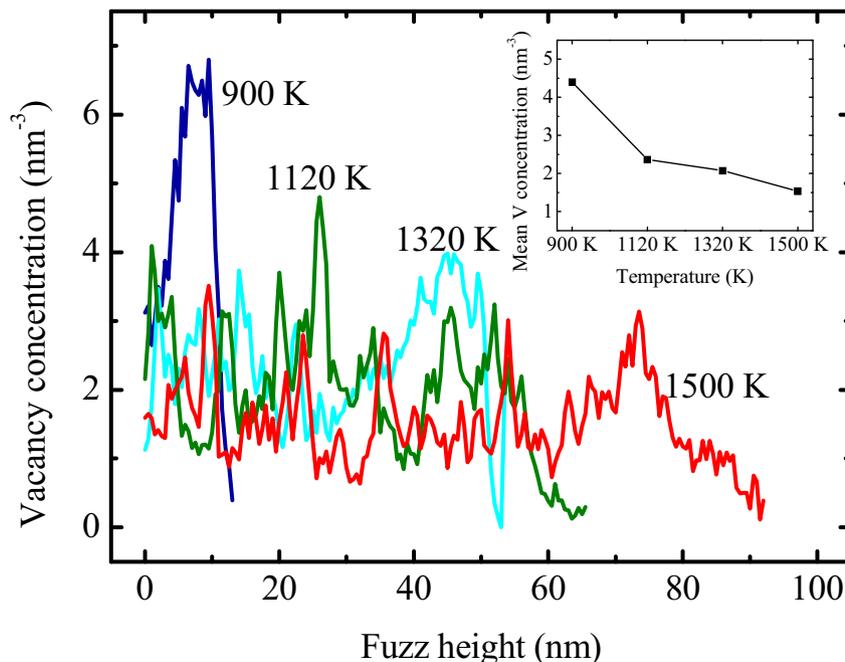


Fig. 8. Vacancy concentration profile in the fuzz region as a function of fuzz height after He irradiation during 3 s at intermediate temperatures (900, 1120, 1320 and 1500 K), at which fuzz growth takes place. Inset: mean vacancy concentration (total number of vacancies/total W-fuzz volume) for 900, 1120, 1320 and 1500 K.

4. Conclusions

In summary, we report an OKMC study on the effect of temperature on fuzz growth in low energy He-irradiated W. In our simulations, fuzz growth is observed in the temperature range from 900 to 2300 K, in agreement with experimental observations. We have identified that fuzz growth is driven by the formation of large He_nV_m clusters, which are only stable at intermediate temperatures (900–1900 K). Two main mechanisms lead to this temperature dependence: (i) emission of SIAs (“trap mutation”) and (ii) coalescence of small He_nV_m clusters due to emission of He atoms and formation of new He_nV_m clusters in their vicinity. At low temperatures (700 K), fuzz growth is prevented by the stability of small He_9V_1 clusters, leading to no He emission. In contrast, at high temperatures (2500 K) fuzz does not grow due to the high He emission from He_nV_m clusters, leading to their dissolution and thus, preventing He retention. We can conclude that fuzz growth is not only influenced by He retention, but by the size and stability of He_nV_m clusters in which He atoms are retained. Regarding the temporal evolution of fuzz growth, our simulations predict an incubation fluence consistent with recent experimental observations. Note that the simulations have been carried out in a pseudo-3D approach. Although the dynamics of He_nV_m clusters formation and dissociation are not influenced by the box size, incubation fluence and fuzz growth rate could be probably better reproduced in full-3D simulations.

Acknowledgements

The authors acknowledge financial support by the Spanish MINECO project ENE-2012-39787-C06-03. The authors also acknowledge CSC, Academy of Finland. This work has been carried out within the framework of the EUROfusion Consortium and has received funding from the Euratom research and training programme 2014–2018 under the grant agreement No 633053. The views and opinions expressed herein do not necessarily reflect those of the European Commission.

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